

IGC06R60DE

TRENCHSTOP[™] RC-Series for hard switching applications

IGBT chip with monolithically integrated diode in packages offering space saving advantage

Features:

TRENCHSTOP[™] Reverse Conducting (RC) technology for 600V applications offering:

- \bullet Optimised V_{CEsat} and V_{F} for low conduction losses
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance
- Qualified according to JEDEC for target applications
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

Applications:

Used for:

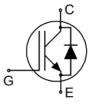
Motor drives

Discrete components and molded modules

Chip Type	V _{CE}	I _{Cn}	Die Size	Package
IGC06R60DE	600V	8A	2.44 x 2.47 mm ²	sawn on foil

Mechanical Parameters

Wechanical Faramet	CI 3	-			
Raster size		2.44 x 2.47			
Emitter pad size		see chip drawing			
Gate pad size		see chip drawing	mm ²		
Area: total / active IGE	3T / active Diode	6.026 / 3.718 / 0.702			
Thickness		70	μm		
Wafer size		200	mm		
Max.possible chips per wafer		4631			
Passivation frontside		Photoimide			
Pad metal		3200 nm AlSiCu			
Backside metal		Ni Ag –system			
Die bond		Electrically conductive epoxy glue and soft solder (temperature budget: 290°C for 1min. or 260°C for 1.5min.)			
Wire bond		Al, <350µm			
Reject ink dot size		Ø 0.65mm ; max 1.2mm			
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month			
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas Humidity <25%RH, Temperature 17°C – 25°C, < 6 month			





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Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, <i>T</i> _{vj} =25 °C	V _{CE}	600	V
DC collector current, limited by $T_{vj max}$	I _C	1)	А
Pulsed collector current, t_p limited by $T_{vj max}$	I _{c,puls}	24	А
Gate emitter voltage	V _{GE}	±20	V
Junction temperature range	T _{vj,max}	-40+175	°C
Operating junction temperature	T _{vj,op,max}	-40+175	°C
Short circuit data 2 $^{3)}$ $V_{GE} = 15V$, $V_{CC} = 400V$, $T_{vj} = 150^{\circ}C$	t _{SC}	5	μs
Safe operating area IGBT ^{2)3)}	$I_{C,max} = 16A, V_{CE,max} = 600V, T_{vj,op} \le T_{vj,op,m}$		
Safe operating area Diode ²)	$I_{F,max} = 16A, V_{R,max} = 600V,$ $P_{max} = 6.6 \text{ kW}, T_{vj,op} \leq T_{vj,op,max}$		

¹⁾ depending on thermal properties of assembly
²⁾ not subject to production test - verified by design/characterization

³⁾ allowed number of short circuits: <1000; time between short circuits: >1s

Parameter	Symbol	Conditions	Value			Unit
i arameter	Gymbol	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	<i>V</i> _{GE} =0V , <i>I</i> _C = 0.2 mA	600			
Collector-Emitter saturation voltage	V _{CEsat}	V _{GE} =15V, <i>I</i> _C =8A		1.65	2.1	
Diode Forward Voltage	V _F	V _{GE} =0V, I _F =8A		1.7	2.1	V
Gate-Emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =0.15mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.3	5	5.7	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V , V_{GE} =0V			40	μA
Gate-Emitter leakage current	I _{GES}	<i>V</i> _{CE} =0V , <i>V</i> _{GE} =20V			100	nA
Integrated gate resistor	r _G			none		Ω

Static Characteristics (tested on wafer), T_{vj} =25 °C

Dynamic Characteristics (not subject to production test - verified by design / characterization), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
Farameter	Symbol	Conditions	min.	typ.	max.	Unit
Input capacitance	Cies	$V_{CE}=25V$,		775		
Output capacitance	Coes	$V_{\rm GE}=0V$,		46		рF
Reverse transfer capacitance	Cres	<i>f</i> =1MHz		23		



Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on package design and mounting technology and can therefore not be specified for a bare die.

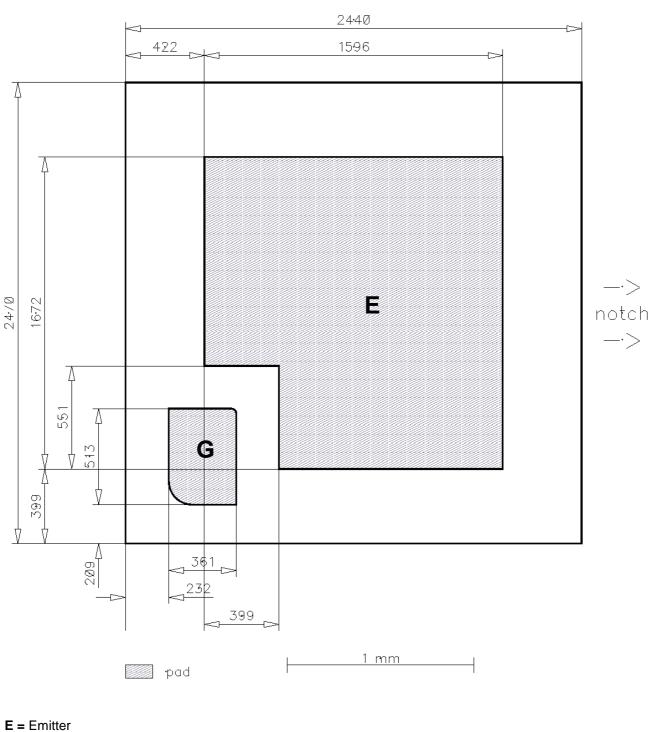
Further technical information about the performance of this chip in package t.b.d. is given exemplarily at www.infineon.com/igbt. The chip qualification is independent of the qualification which is performed for the Discretes.



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Chip Drawing



Die−Size 2440 um x 2470 um

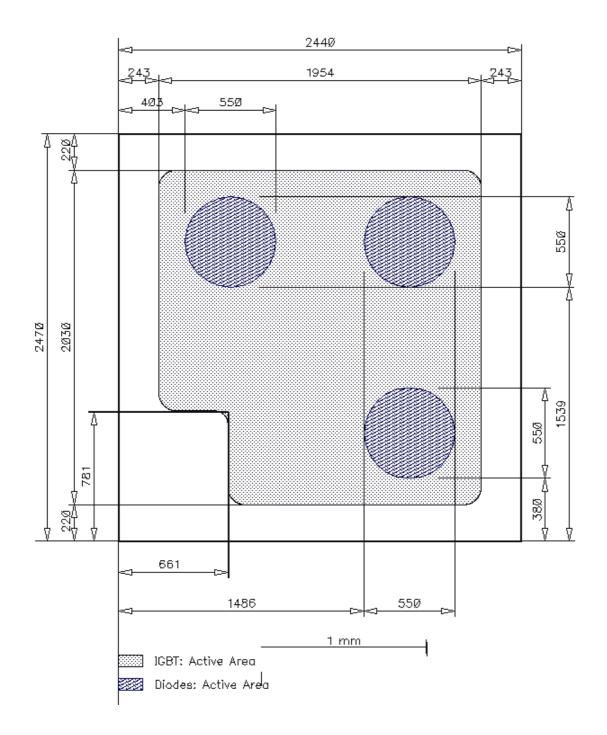
G = Gate



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Chip Drawing active areas

Die-Size 2440 um x 2470 um





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Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

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